# imall

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# **Power MOSFET**

# -20 V, -4.1 A, Dual P-Channel, 2x2 mm WDFN Package

## Features

- WDFN Package Provides Exposed Drain Pad for Excellent Thermal Conduction
- 2x2 mm Footprint Same as SC-88
- Lowest R<sub>DS(on)</sub> Solution in 2x2 mm Package
- 1.8 V R<sub>DS(on)</sub> Rating for Operation at Low Voltage Gate Drive Logic Level
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- Bidirectional Current Flow with Common Source Configuration
- This is a Pb–Free Device

## Applications

- Optimized for Battery and Load Management Applications in Portable Equipment
- Li-Ion Battery Charging and Protection Circuits
- High Side Load Switch

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V
Gate-to-Source Voltage			V <sub>GS</sub>	±8.0	V
Continuous Drain Current (Note 1)	Steady State	$T_A = 25^{\circ}C$	I <sub>D</sub>	-3.3	А
		$T_A = 85^{\circ}C$		-2.4	
	t ≤ 5 s	$T_A = 25^{\circ}C$		-4.1	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	PD	1.5	W
	t ≤ 5 s			2.3	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	-2.3	А
Current (Note 2)		$T_A = 85^{\circ}C$		-1.6	
Power Dissipation (Note 2)	State	$T_A = 25^{\circ}C$	PD	0.71	W
Pulsed Drain Current	t <sub>p</sub> = 10 μs		I <sub>DM</sub>	-20	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Source Current (Body Diode) (Note 2)			۱ <sub>S</sub>	-1.9	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

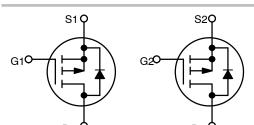
 Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz Cu.



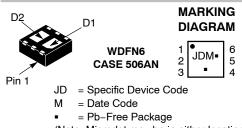
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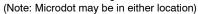
#### www.onsemi.com

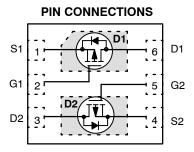
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	ID MAX (Note 1)
	100 mΩ @ –4.5 V	
-20 V	135 mΩ @ –2.5 V	-4.1 A
	200 mΩ @ –1.8 V	



D1 O D2 O







(Top View)

## ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTLJD3115PT1G	WDFN6 (Pb-Free)	3000/Tape & Reel
NTLJD3115PTAG	WDFN6 (Pb–Free)	3000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

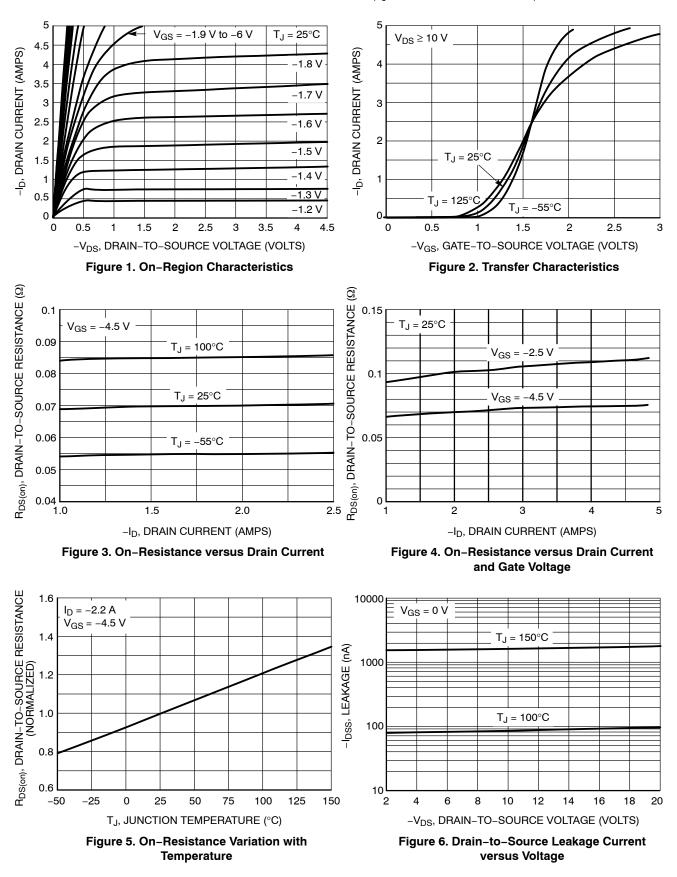
Parameter	Symbol	Max	Unit	
SINGLE OPERATION (SELF-HEATED)				
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	83		
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ hetaJA}$	177	°C/W	
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	$R_{ hetaJA}$	54		
DUAL OPERATION (EQUALLY HEATED)				
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	58		
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ heta JA}$	133	°C/W	
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	R <sub>0JA</sub>	40		

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm<sup>2</sup>, 2 oz Cu).

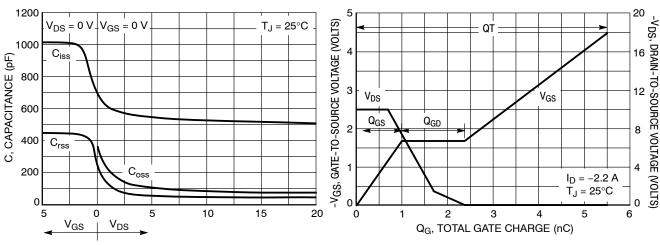
# **MOSFET ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Test Condition	าร	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -2$	50 μΑ	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = -250 \ \mu A$ , Ref to $25^{\circ}C$			9.95		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -16 V, V <sub>GS</sub> = 0 V	$T_J = 25^{\circ}C$			-1.0	μΑ
			T <sub>J</sub> = 85°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±	8.0 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -2$	50 μA	-0.4	-0.7	-1.0	V
Negative Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				2.44		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5, I <sub>D</sub> = -2.0 A			75	100	mΩ
		V <sub>GS</sub> = -2.5, I <sub>D</sub> = -2.0 A			101	135	
		V <sub>GS</sub> = -1.8, I <sub>D</sub> = -	1.6 A		150	200	1
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = -5.0 V, I <sub>D</sub> = -2.0 A			6.0		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	CE					
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = -10 V			531		pF
Output Capacitance	C <sub>OSS</sub>				91		
Reverse Transfer Capacitance	C <sub>RSS</sub>				56		
Total Gate Charge	Q <sub>G(TOT)</sub>				5.5	6.2	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = -4.5 V, $V_{DS}$ = -10 V, $I_D$ = -2.0 A			0.7		-
Gate-to-Source Charge	Q <sub>GS</sub>				1.0		
Gate-to-Drain Charge	Q <sub>GD</sub>				1.4		
Gate Resistance	R <sub>G</sub>				8.8		Ω
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn–On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = -4.5 V, $V_{DD}$ = -5.0 V, I <sub>D</sub> = -1.0 A, R <sub>G</sub> = 6.0 $\Omega$			6.0		ns
Rise Time	t <sub>r</sub>				11		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				21		
Fall Time	t <sub>f</sub>				8.0		
Turn–On Delay Time	t <sub>d(ON)</sub>				6.0		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DD</sub> =	–10 V,		12		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{\rm D} = -2.0 \text{ A}, R_{\rm G} = 2.0 \Omega$			19		
Fall Time	t <sub>f</sub>				6.0		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				-		
Forward Recovery Voltage	V <sub>SD</sub>		$T_J = 25^{\circ}C$		-0.75	-1.0	v v
		$V_{GS} = 0 V, IS = -1.0 A$	T <sub>J</sub> = 125°C		-0.64		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, d <sub>ISD</sub> /d <sub>t</sub> = 100 A/µs, I <sub>S</sub> = -1.0 A			12.6	<u> </u>	1
Charge Time	t <sub>a</sub>				7.0	<u> </u>	ns
Discharge Time	t <sub>b</sub>				5.6		
							1

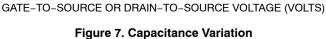
 $\begin{array}{ll} \text{5. Pulse Test: Pulse Width} \leq 300 \ \mu\text{s}, \ \text{Duty Cycle} \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

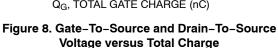


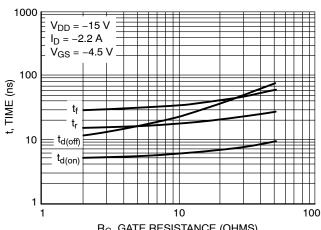
TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



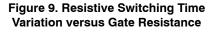
#### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)











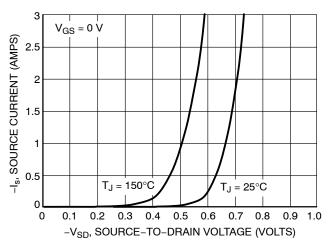
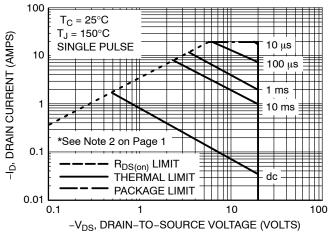
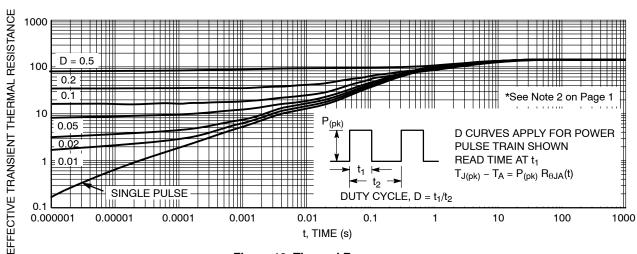


Figure 10. Diode Forward Voltage versus Current







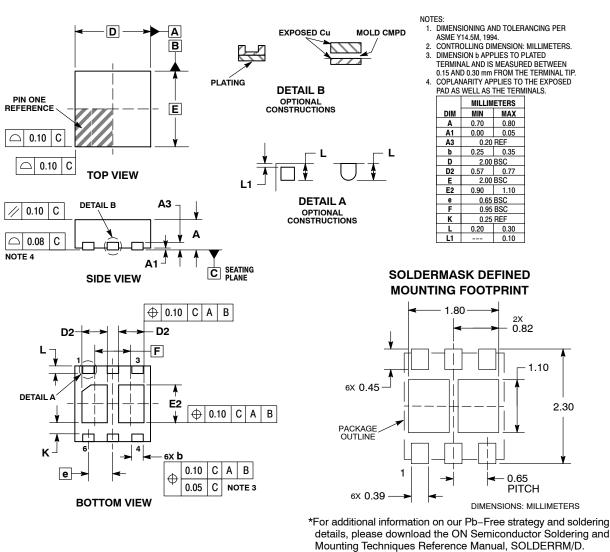
## TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

Figure 12. Thermal Response

#### PACKAGE DIMENSIONS

#### WDFN6, 2x2 CASE 506AN

ISSUE G



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